

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/808,881	SOMERVILL ET AL.	ERVILL ET AL.
Examiner	Art Unit	nit
Gonal C. Ray	2111	

	SEARCHED				
Class	Subclass	Date	Examiner		
710	316,302- 304,104,7 2,305,107, 307	6/22/2006	GCR		
710	317,37	6/22/2006	GCR		
713	1,323	6/22/2006	GCR		
370	464,362	6/22/2006	GCR		
370	364,357	6/22/2006	GCR		
370	916	6/2/2006	GCR		
712	29	6/22/2006	GCR		
709	253	6/22/2006	GCR		
716	12	6/2/2006	GCR		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
US PGPUB text search - see interference search printout		6/22/2006	GCR		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
WEST: PGPG, USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDB (see search history printouts)	6/22/2006	GCR	
EAST: USPT (see search history printouts)	6/22/2006	GCR	
NPL: IEEE Xplore (see search history printouts)	6/22/2006	GCR	